February 1999 PRELIMINARY

# FDD5202P

# **FDD5202P** P-Channel, Logic Level, MOSFET

## **General Description**

FAIRCHILD

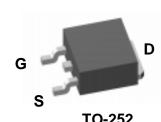
This P-Channel Logic level MOSFET is produced using Fairchild Semiconductor's advanced process that has been especially tailored to minimize the on state resistance and yet maintain low gate charge for superior switching performance.

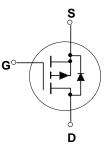
## Applications

- DC/DC converter
- Motor drives
- L.D.O.

## Features

- -8 A, -60 V.  $R_{DS(on)} = 0.3 \ \Omega \ @ V_{GS} = -10 \ V$  $\mathsf{R}_{\mathsf{DS(on)}} = 0.5 \ \Omega \ @ \ \mathsf{V}_\mathsf{GS} = -4.5 \ \mathsf{V}.$
- Low gate charge (15.5nC typical).
- Fast switching speed.







Absolute Maximum R	<u>latings</u>	a=25°C unless otherwise not	ed

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-60	V
V <sub>GSS</sub>	Gate-Source Voltage		<u>+</u> 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	-8	А
		(Note 1a)	-2.3	
	- Pulsed		-15	
P <sub>D</sub> I	Maximum Power Dissipation @ $T_c = 25^{\circ}C$	(Note 1)	39	W
	$T_A = 25^{\circ}C$	(Note 1a)	2.8	
	$T_A = 25^{\circ}C$	(Note 1b)	1.3	
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

R <sub>θ</sub> JC	Thermal Resistance, Junction-to- Case	(Note 1)	3.2	∘C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to- Ambient	(Note 1b)	96	°C/W

# Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDD5202P	FDD5202P	13"	16mm	2500

**Electrical Characteristics** T<sub>A</sub> = 25°C unless otherwise noted Symbol Units Parameter Min Тур Max **Test Conditions Off Characteristics** Drain-Source Breakdown  $V_{GS} = 0 \text{ V}, I_D = -250 \ \mu\text{A}$ V  $BV_{DSS}$ -60 Voltage ABVDSS Breakdown Voltage  $I_D = -250 \ \mu$ A, Referenced to  $25^{\circ}$ C -60 mV/∘C Temperature Coefficient  $\Delta T_J$ μA Zero Gate Voltage Drain  $V_{DS} = -48 V, V_{GS} = 0 V$ -1 IDSS Current  $V_{GS} = 20V, V_{DS} = 0 V$ Gate-Body Leakage Current, 100 IGSSF nΑ Forward  $I_{GSSR}$ Gate-Body Leakage Current,  $V_{GS} = -20 V, V_{DS} = 0 V$ -100 nA Reverse On Characteristics (Note 2) V<sub>GS(th)</sub> Gate Threshold Voltage  $V_{DS} = V_{GS}$ ,  $I_D = -250 \ \mu A$ -2 -2.3 -4 V Gate Threshold Voltage  $I_D$  = -250  $\mu$ A, Referenced to 25°C mV/∘C  $\Delta VGS(th)$ 3.2  $\Delta T_{J}$ **Temperature Coefficient** R<sub>DS(on)</sub> Static Drain-Source  $V_{GS} = -10 \text{ V}, I_{D} = -2.3 \text{ A}$ 0.205 0.300 Ω **On-Resistance** V<sub>GS</sub> = -10 V, I<sub>D</sub> = -2.3 A,T<sub>J</sub>=125°C 0.340 0.510  $V_{GS} = -4.5 \text{ V}, I_D = -1.8 \text{ A}$ 0.313 0.500  $V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$ **On-State Drain Current** -10 А I<sub>D(on)</sub> Forward Transconductance  $V_{\text{DS}}$  = -5 V,  $I_{\text{D}}$  = -2.3 A 3 S **g**<sub>FS</sub> **Dynamic Characteristics**  $V_{DS} = -30 V, V_{GS} = 0 V,$ pF Input Capacitance 560 Ciss f = 1.0 MHz $C_{\text{oss}}$ pF **Output Capacitance** 130  $C_{\text{rss}}$ Reverse Transfer Capacitance 35 pF Switching Characteristics (Note 2) Turn-On Delay Time  $V_{DD} = -30 V, I_D = -1 A,$ 8 15 ns t<sub>d(on)</sub>  $V_{GS}$  = -10 V,  $R_{GEN}$  = 6  $\Omega$ Turn-On Rise Time 20 40 ns Turn-Off Delay Time 20 40 t<sub>d(off)</sub> ns Turn-Off Fall Time 5 20 ns  $V_{DS} = -30 V$ ,  $I_D = -2.3 A$ ,  $Q_g$ **Total Gate Charge** 15.5 22 nC  $V_{GS}$  = -10 V  $\mathsf{Q}_{\mathsf{gs}}$ Gate-Source Charge 2.4 nC Q<sub>gd</sub> Gate-Drain Charge 4.7 nC Drain-Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current -2.2 А  $V_{\text{SD}}$ Drain-Source Diode Forward  $V_{GS} = 0 V, I_S = -2.2 A$  (Note 2) -1 -1.3 V Voltage 1. R<sub>0JA</sub> is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the drain tab.  $\rm R_{\theta JC}$  is guaranteed by design while  $\rm R_{\theta JA}$  is determined by the user's board design. b)  $R_{\theta JA}^{}= 96^{\circ}C/W$  when mounted on a)  $R_{\theta JA}$ = 45<sup>o</sup>C/W when mounted

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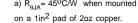
Notes:

 $I_{S}$ 

tr

 $\mathbf{t}_{\mathrm{f}}$ 



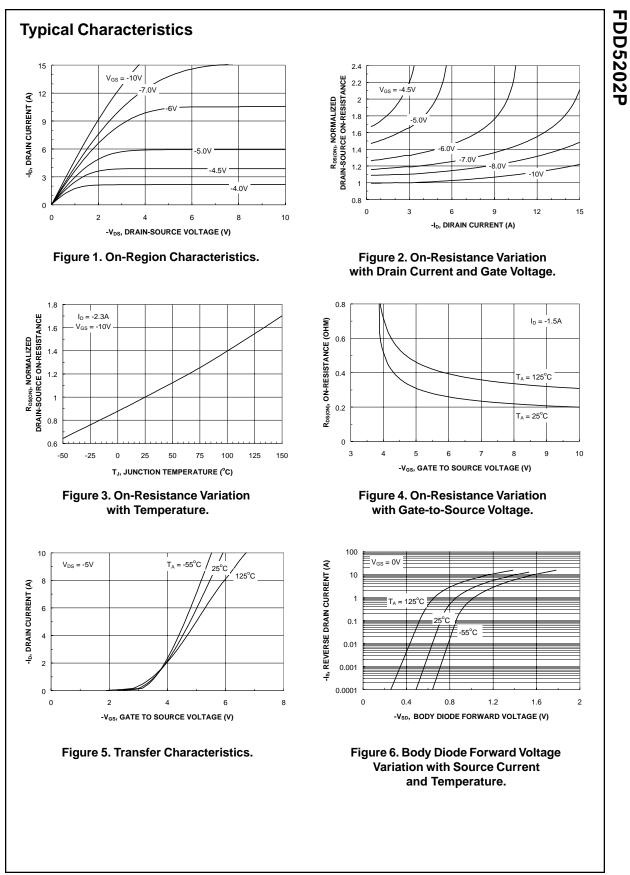




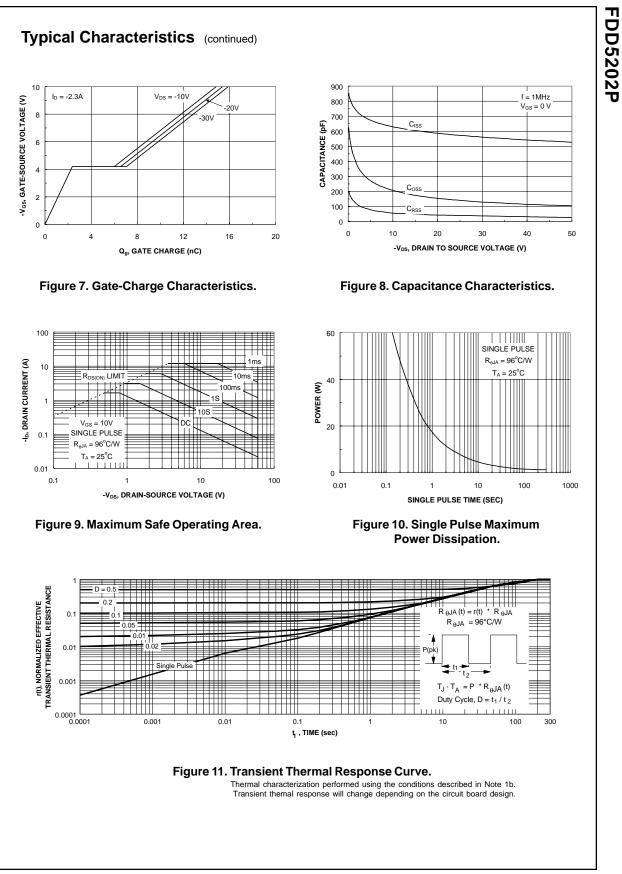
a 0.076 in<sup>2</sup> pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq 300~\mu s,$  Duty Cycle  $\leq 2.0\%$ 



FDD5202P, Rev. A



FDD5202P, Rev. A

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